

#### Description

The VSM82P06 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge .This device is well suited for high current load applications.

#### **General Features**

V<sub>DS</sub> =-60V,I<sub>D</sub> =-82A

 $R_{DS(ON)}$  <13m $\Omega$  @  $V_{GS}$ =-10V

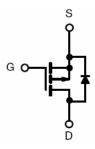
 $R_{DS(ON)}$  <16m $\Omega$  @  $V_{GS}$ =-4.5V

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E<sub>AS</sub>
- Excellent package for good heat dissipation

#### **Application**

Load switch





Schematic Diagram

## **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM82P06-TC	VSM82P06	TO-220C	-	-	-

#### Absolute Maximum Ratings (T<sub>C</sub>=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	-60	V	
Gate-Source Voltage	V <sub>G</sub> s	±20	V	
Drain Current-Continuous	I <sub>D</sub>	-82	А	
Drain Current-Continuous(T <sub>C</sub> =100 °C)	I <sub>D</sub> (100℃)	-58	А	
Pulsed Drain Current	I <sub>DM</sub>	-328	А	
Maximum Power Dissipation	P <sub>D</sub>	150	W	
Derating factor		1.0	W/°C	
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	722	mJ	
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 175	$^{\circ}\!\mathbb{C}$	



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#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup>	R <sub>eJC</sub>	1.0	°C/W	ĺ
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#### Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250µA	-60	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-60V,V <sub>GS</sub> =0V	-	-	-1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)	·					
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA	-1.2	-1.8	-2.4	V
Drain Sauras On State Desistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A	-	11	13	mΩ
Drain-Source On-State Resistance		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-20A	-	13	16	mΩ
Forward Transconductance	<b>g</b> Fs	V <sub>DS</sub> =-5V,I <sub>D</sub> =-20A	-	25	-	S
Dynamic Characteristics (Note4)	·		•			
Input Capacitance	C <sub>lss</sub>	\/ 20\/\/ 0\/	-	5604	-	PF
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =-30V, $V_{GS}$ =0V, F=1.0MHz	-	356	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.UIVIHZ	-	265	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>		-	18	-	nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =-30V, $R_L$ =1.5 $\Omega$ , $V_{GS}$ =-10V, $R_G$ =3 $\Omega$	-	20	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	55	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	35	-	nS
Total Gate Charge	Qg	V - 20 I - 20 A	-	62.1		nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ =-30, $I_{D}$ =-20A, $V_{GS}$ =-10V	-	9.3		nC
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =-10V	-	16.8		nC
Drain-Source Diode Characteristics	•		•			•
Diode Forward Voltage (Note 3)	$V_{SD}$	V <sub>GS</sub> =0V,I <sub>S</sub> =-20A	-		-1.2	V
Diode Forward Current (Note 2)	Is		-	-	-82	А
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, I <sub>F</sub> =-20A	-	49		nS
Reverse Recovery Charge	Qrr	di/dt = -100A/µs <sup>(Note3)</sup>	-	71		nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

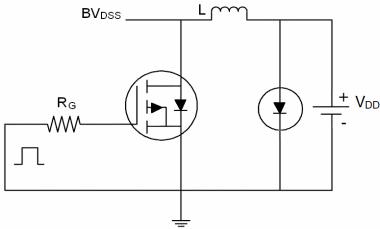
#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- **4.** Guaranteed by design, not subject to production
- **5.** E<sub>AS</sub> condition: Tj=25  $^{\circ}\text{C}$  ,V<sub>DD</sub>=-30V,V<sub>G</sub>=-10V,L=0.5mH,Rg=25 $\Omega$

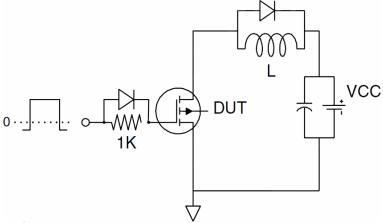


### **Test Circuit**

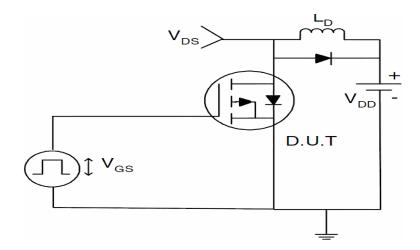
# 1) E<sub>AS</sub> Test Circuit



# 2) Gate Charge Test Circuit

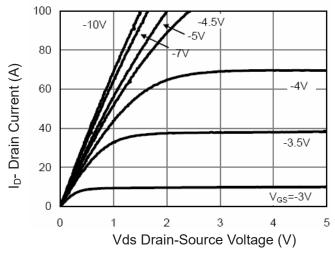


## 3) Switch Time Test Circuit

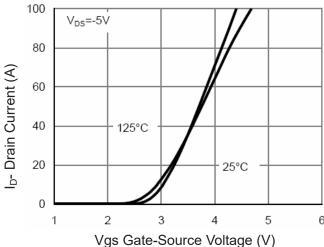




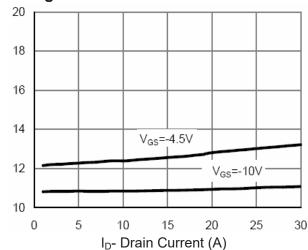
#### Typical Electrical and Thermal Characteristics (Curves)



**Figure 1 Output Characteristics** 

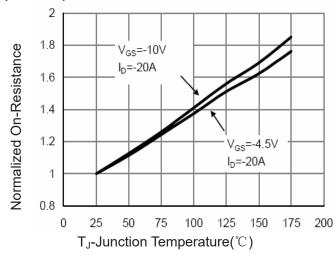


**Figure 2 Transfer Characteristics** 



Rdson On-Resistance(m 2)

Figure 3 Rdson- Drain Current



**Figure 4 Rdson-Junction Temperature** 

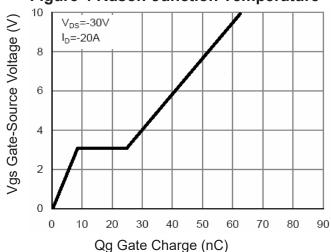


Figure 5 Gate Charge

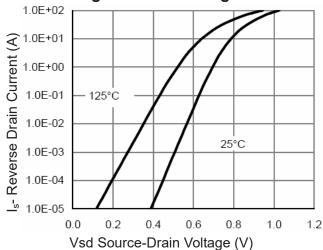


Figure 6 Source- Drain Diode Forward



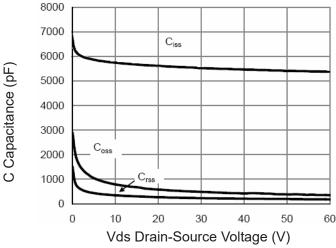
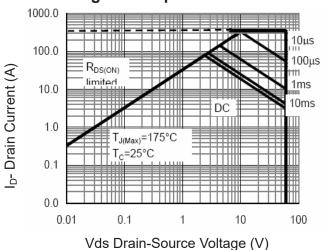


Figure 7 Capacitance vs Vds



**Figure 8 Safe Operation Area** 

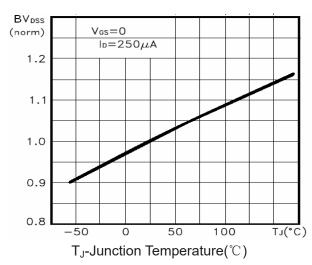


Figure 9 BV<sub>DSS</sub> vs Junction Temperature

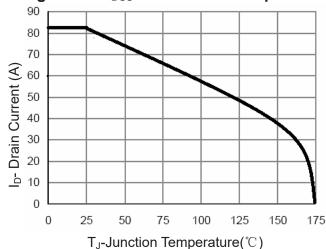


Figure 10 ID Current Derating vs Junction Temperature

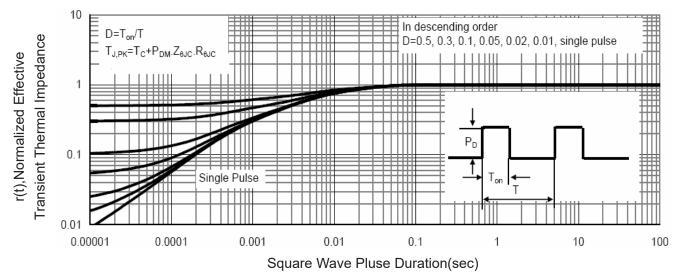


Figure 11 Normalized Maximum Transient Thermal Impedance